

<b>Notice of References Cited</b>	Application/Control No. 10/601,320	Applicant(s)/Patent Under Reexamination WANG, YE-KUI	
	Examiner Philip B. Tran	Art Unit 2155	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0021814	01-2005	Wang, Ye-Kui	709/231
*	B	US-2001/0029548	10-2001	Srikantan et al.	709/231
*	C	US-5,778,143	07-1998	Boyce, Jill MacDonald	375/240.23
*	D	US-6,304,295	10-2001	Krishnamurthy et al.	375/240.24
*	E	US-5,361,096	11-1994	Ohki et al.	348/386.1
*	F	US-6,940,904	09-2005	Chen et al.	375/240.12
*	G	US-7,133,451	11-2006	Kim et al.	375/240.16
*	H	US-6,570,922	05-2003	Wang et al.	375/240.12
*	I	US-6,831,949	12-2004	Brightwell et al.	375/240.12
*	J	US-2002/0147980	10-2002	Satoda, Kozo	725/90
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.